SCOPE OF ACCREDITATION TO ISO/IEC 17025:2005
& ANSI/NCSL Z-540-1-1994 & ANSI/NCSL Z-540.3-2006

ALPHA CONTROLS AND INSTRUMENTATION
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CALIBRATION

Valid To: January 31, 2013 Certificate Number: 2260.01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations[1]

I. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC[2, 4] (±)	Comments
DC Voltage – Measure	Up to 200 mV (0.2 to 2) V (2 to 20) V (20 to 200) V (200 to 1000) V	5 µV/V + 0.1 µV 3.5 µV/V + 0.4 µV 3.5 µV/V + 4 µV 5.5 µV/V + 40 µV 5.5 µV/V + 0.5 mV	Fluke 8508A
DC Voltage – Generate	(0 to 330) mV 330 mV to 3.3 V (3.3 to 33) V (33 to 330) V (330 to 1000) V	20 µV/V + 1 µV 11 µV/V + 2 µV 12 µV/V + 20 µV 18 µV/V + 150 µV 18 µV/V + 1.5 mV	Fluke 5520A
DC Current – Measure	Up to 200 µA 200 µA to 2 mA (2 to 20) mA (20 to 200) mA 200 mA to 2 A (2 to 20) A	12 µA/A + 0.4 nA 12 µA/A + 4 nA 14 µA/A + 40 nA 48 µA/A + 0.8 µA 0.01 % + 16 µA 0.02 % + 400 µA	Fluke 8508A

Parameter/Equipment	Range	CMC[2, 4] (±)	Comments
DC Current – Generate	Up to 330 µA 330 µA to 3.3 mA (3.3 to 33) mA (33 to 330) mA 330 mA to 1.1 A (1.1 to 3) A (3 to 11) A (11 to 20.5) A	0.015 % + 0.02 µA 0.01 % + 0.05 µA 0.01 % + 0.25 µA 0.01 % + 2.5 µA 0.02 % + 40 µA 0.038 % + 40 µA 0.05 % + 500 µA 0.1 % + 750 µA	Fluke 5520A
Clamp-On Only	(0 to 1000) A	0.27 % + 0.062 A	Fluke 5500A/coil
Resistance – Measure[5]	Up to 2 Ω (2 to 20) Ω (20 to 200) Ω 200 Ω to 2 kΩ (2 to 20) kΩ (20 to 200) kΩ 200 kΩ to 2 MΩ (2 to 20) MΩ (20 to 200) MΩ 200 MΩ to 2 GΩ	17 µΩ/Ω + 4 µΩ 9.5 µΩ/Ω + 14 µΩ 8 µΩ/Ω + 50 µΩ 8 µΩ/Ω + 500 µΩ 8 µΩ/Ω + 5 mΩ 8 µΩ/Ω + 50 mΩ 9 µΩ/Ω + 1 Ω 20 µΩ/Ω + 100 Ω 0.012 % + 10 kΩ 1.6 mΩ/Ω + 1 MΩ	Fluke 8508A
Resistance – Generate[5]	(0 to 11) Ω (11 to 33) Ω (33 to 110) Ω (110 to 330) Ω 330 Ω to 1.1 kΩ (1.1 to 3.3) kΩ (3.3 to 11) kΩ (11 to 33) kΩ (33 to 110) kΩ (110 to 330) kΩ 330 kΩ to 1.1 MΩ (1.1 to 3.3) MΩ (3.3 to 11) MΩ (11 to 33) MΩ (33 to 110) MΩ (110 to 330) MΩ 330 MΩ to 1.1 GΩ	40 µΩ/Ω + 0.01 Ω 30 µΩ/Ω + 0.015 Ω 28 µΩ/Ω + 0.015 Ω 28 µΩ/Ω + 0.02 Ω 28 µΩ/Ω + 0.02 Ω 28 µΩ/Ω + 0.2 Ω 28 µΩ/Ω + 0.1 Ω 28 µΩ/Ω + 1 Ω 28 µΩ/Ω + 1 Ω 32 µΩ/Ω + 10 Ω 32 µΩ/Ω + 10 Ω 60 µΩ/Ω + 150 Ω 0.013 % + 250 Ω 0.025 % + 2.5 kΩ 0.05 % + 3 kΩ 0.3 % + 100 kΩ 1.5 % + 500 kΩ	Fluke 5520A
Fixed Points	25 Ω 100 Ω 200 Ω 400 Ω	6 µΩ/Ω 6 µΩ/Ω 6 µΩ/Ω 6 µΩ/Ω	Hart Scientific 3591

Parameter/Range	Frequency	CMC[2, 4] (±)	Comments
AC Voltage – Measure			
Up to 200 mV	(1 to 10) Hz (10 to 40) Hz (40 to 100) Hz 100 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz	0.017 % + 14 µV 0.014 % + 4 µV 0.012 % + 4 µV 0.011 % + 2 µV 0.014 % + 4 µV 0.034 % + 8 µV 0.077 % + 20 µV	Fluke 8508A
200 mV to 2 V	(1 to 10) Hz (10 to 40) Hz (40 to 100) Hz 100 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.015 % + 120 µV 0.012 % + 20 µV 90 µV/V + 20 µV 75 µV/V + 20 µV 0.011 % + 20 µV 0.022 % + 40 µV 0.057 % + 200 µV 0.3 % + 2 mV 1 % + 20 mV	
(2 to 20) V	(1 to 10) Hz (10 to 40) Hz (40 to 100) Hz 100 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.015 % + 1.2 mV 0.011 % + 200 µV 90 µV/V + 200 µV 75 µV/V + 200 µV 0.011 % + 200 µV 0.022 % + 400 µV 0.057 % + 2 mV 0.3 % + 20 mV 1 % + 200 mV	
(20 to 200) V	(1 to 10) Hz (10 to 40) Hz (40 to 100) Hz 100 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz (30 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.015 % + 12 mV 0.012 % + 2 mV 90 µV/V + 2 mV 75 µV/V + 2 mV 0.011 % + 2 mV 0.022 % + 4 mV 0.057 % + 20 mV 0.3 % + 20 mV 1 % + 200 mV	

Parameter/Range	Frequency	CMC[2, 4] (±)	Comments
AC Voltage – Measure (cont)			
(200 to 300) V	(1 to 10) Hz (10 to 40) Hz 40 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.015 % + 21 mV 0.012 % + 6 mV 0.012 % + 6 mV 0.023 % + 12 mV 0.058 % + 60 mV	Fluke 8508A
(300 to 1050) V	(1 to 10) Hz (10 to 40) Hz 40 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.015 % + 70 mV 0.012 % + 20 mV 0.012 % + 20 mV 0.023 % + 40 mV 0.058 % + 200 mV	
AC Voltage – Generate			
(1 to 33) mV	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 500) kHz	0.08 % + 6 µV 0.015 % + 6 µV 0.02 % + 6 µV 0.1 % + 6 µV 0.35 % + 12 µV 0.8 % + 50 µV	Fluke 5520A
(33 to 330) mV	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 500) kHz	0.03 % + 8 µV 0.015 % + 8 µV 0.016 % + 8 µV 0.035 % + 8 µV 0.08 % + 32 µV 0.2 % + 70 µV	
(0.33 to 3.3) V	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 500) kHz	0.03 % + 50 µV 0.015 % + 60 µV 0.019 % + 60 µV 0.03 % + 50 µV 0.07 % + 130 µV 0.24 % + 600 µV	
(3.3 to 33) V	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.03 % + 650 µV 0.015 % + 600 µV 0.024 % + 600 µV 0.035 % + 600 µV 0.09 % + 1.6 mV	

Parameter/Range	Frequency	CMC[2, 4] (±)	Comments
AC Voltage – Generate (cont)			
(33 to 330) V	45 Hz to 1 kHz (1 to 10) kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.019 % + 2 mV 0.02 % + 6 mV 0.025 % + 6 mV 0.03 % + 6 mV 0.2 % + 50 mV	Fluke 5520A
(330 to 1020) V	45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.03 % + 10 mV 0.025 % + 10 mV 0.03 % + 10 mV	
AC Current – Measure			
Up to 200 μA	(1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.031 % + 20 nA 0.03 % + 20 nA 0.071 % + 20 nA 0.4 % + 20 nA	Fluke 8508A
200 μA to 2 mA	(1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.031 % + 200 nA 0.03 % + 200 nA 0.071 % + 200 nA 0.4 % + 200 nA	
(2 to 20) mA	(1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz (30 to 100) kHz	0.031 % + 2 μA 0.03 % + 2 μA 0.071 % + 2 μA 0.4 % + 2 μA	
(20 to 200) mA	(1 to 10) Hz 10 Hz to 10 kHz (10 to 30) kHz	0.031 % + 20 μA 0.029 % + 20 μA 0.063 % + 20 μA	
200 mA to 2 A	10 Hz to 2 kHz (2 to 10) kHz (10 to 30) kHz	0.062 % + 200 μA 0.073 % + 200 μA 0.3 % + 200 μA	
(2 to 20) A	10 Hz to 2 kHz (2 to 10) kHz	0.082 % + 2 mA 0.25 % + 2 mA	

Parameter/Range	Frequency	CMC[2, 4] (±)	Comments
AC Current – Generate			
(29 to 330) µA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.2 % + 0.1 µA 0.15 % + 0.1 µA 0.13 % + 0.1 µA 0.3 % + 0.15 µA 0.8 % + 0.2 µA 1.6 % + 0.4 µA	Fluke 5520A
(0.33 to 3.3) mA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.2 % + 0.15 µA 0.13 % + 0.15 µA 0.1 % + 0.15 µA 0.2 % + 0.2 µA 0.5 % + 0.3 µA 1 % + 0.6 µA	
(3.3 to 33) mA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.18 % + 2 µA 0.09 % + 2 µA 0.04 % + 2 µA 0.08 % + 2 µA 0.2 % + 3 µA 0.4 % + 4 µA	
(33 to 330) mA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.18 % + 20 µA 0.09 % + 20 µA 0.04 % + 20 µA 0.1 % + 50 µA 0.2 % + 100 µA 0.4 % + 200 µA	
(0.33 to 3) A	(10 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.18 % + 100 µA 0.06 % + 100 µA 0.6 % + 1000 µA 2.5 % + 5000 µA	
(3 to 11) A	(45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.06 % + 2 mA 0.1 % + 2 mA 3 % + 2 mA	
(11 to 20.5) A	(45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.12 % + 5 mA 0.15 % + 5 mA 3 % + 5 mA	
Clamp-On Only (0 to 1000) A	(45 to 65) Hz (65 to 440) Hz	0.3 % + 0.14 A 1.3 % + 0.27 A	Fluke 5500A/coil

Parameter/Range	Frequency	CMC[2, 4] (±)	Comments
Capacitance – Generate			
(0.19 to 0.4) nF	10 Hz to 10 kHz	0.05 % + 0.01 nF	Fluke 5520A
(0.4 to 1.1) nF	10 Hz to 10 kHz	0.05 % + 0.01 nF	
(1.1 to 3.3) nF	10 Hz to 3 kHz	0.05 % + 0.01 nF	
(3.3 to 11) nF	10 Hz to 1 kHz	0.25 % + 0.01 nF	
(11 to 33) nF	10 Hz to 1 kHz	0.25 % + 0.1 nF	
(33 to 110) nF	10 Hz to 1 kHz	0.25 % + 0.1 nF	
(110 to 330) nF	10 Hz to 1 kHz	0.25 % + 0.3 nF	
(0.33 to 1.1) µF	(10 to 600) Hz	0.25 % + 1 nF	
(1.1 to 3.3) µF	(10 to 300) Hz	0.25 % + 3 nF	
(3.3 to 11) µF	(10 to 150) Hz	0.25 % + 10 nF	
(11 to 33) µF	(10 to 120) Hz	0.4 % + 30 nF	
(33 to 110) µF	(10 to 80) Hz	0.45 % + 100 nF	
(110 to 330) µF	Up to 50 Hz	0.45 % + 300 nF	
(0.33 to 1.1) mF	Up to 20 Hz	0.45 % + 1 µF	
(1.1 to 3.3) mF	Up to 6 Hz	0.45 % + 3 µF	
(3.3 to 11) mF	Up to 2 Hz	0.45 % + 10 µF	
(11 to 33) mF	Up to 0.6 Hz	0.75 % + 30 µF	
(33 to 110) mF	Up to 0.2 Hz	1.1 % + 100 µF	

Parameter/Equipment	Range	CMC[2] (±)	Comments
Electrical Calibration of Thermocouples and Thermocouple Indicating Devices – Measure and Generate			
Type E	(-250 to -100) ºC	0.50 °C	Fluke 5520A
	(-100 to -25) ºC	0.16 °C	
	(-25 to 350) ºC	0.14 °C	
	(350 to 650) ºC	0.16 °C	
	(650 to 1000) ºC	0.21 °C	
Type J	(-210 to -100) ºC	0.27 °C	
	(-100 to -30) ºC	0.16 °C	
	(-30 to 150) ºC	0.14 °C	
	(150 to 760) °C	0.17 °C	
	(760 to 1200) °C	0.23 °C	
Type K	(-200 to -100) ºC	0.33 °C	
	(-100 to -25) ºC	0.18 °C	
	(-25 to 120) ºC	0.16 °C	
	(120 to 1000) ºC	0.26 °C	
	(1000 to 1372) ºC	0.4 °C	

Parameter/Equipment	Range	CMC[2] (±)	Comments
Electrical Calibration of Thermocouples and Thermocouple Indicating Devices – Measure and Generate (cont)			
Type N	(-200 to -100) ºC (-100 to -25) ºC (-25 to 120) ºC (120 to 410) ºC (410 to 1300) ºC	0.40 °C 0.22 °C 0.19 °C 0.18 °C 0.27 °C	Fluke 5520A
Type R	(0 to 250) ºC (250 to 400) ºC (400 to 1000) ºC (1000 to 1767) ºC	0.57 °C 0.35 °C 0.33 °C 0.40 °C	
Type S	(0 to 250) ºC (250 to 1000) ºC (1000 to 1400) ºC (1400 to 1767) ºC	0.47 °C 0.36 °C 0.37 °C 0.46 °C	
Type T	(-250 to -150) ºC (-150 to 0) ºC (0 to 120) ºC (120 to 400) ºC	0.63 °C 0.24 °C 0.16 °C 0.14 °C	
Electrical Calibration of RTD Indicating Devices – Generate[5]			
Pt 385, 100 Ω	(-200 to -80) ºC (-80 to 0) ºC (0 to 100) ºC (100 to 300) ºC (300 to 400) ºC (400 to 630) ºC (630 to 800) ºC	0.05 ºC 0.05 ºC 0.07 ºC 0.09 ºC 0.1 ºC 0.12 ºC 0.23 ºC	Fluke 5520A
Pt 3926, 100 Ω	(-200 to -80) ºC (-80 to 0) ºC (0 to 100) ºC (100 to 300) ºC (300 to 400) ºC (400 to 630) ºC	0.05 ºC 0.05 ºC 0.07 ºC 0.09 ºC 0.1 ºC 0.12 ºC	

Parameter/Equipment	Range	CMC[2] (±)	Comments
Electrical Calibration of RTD Indicating Devices – Generate[5] (cont)			
Pt 3916, 100 Ω	(-200 to -190) ºC (-190 to -80) ºC (-80 to 0) ºC (0 to 100) ºC (100 to 260) ºC (260 to 300) ºC (300 to 400) ºC (400 to 600) ºC (600 to 630) ºC	0.25 ºC 0.04 ºC 0.05 ºC 0.06 ºC 0.07 ºC 0.08 ºC 0.09 ºC 0.1 ºC 0.23 ºC	Fluke 5520A
Pt 385, 200 Ω	(-200 to -80) ºC (-80 to 0) ºC (0 to 100) ºC (100 to 260) ºC (260 to 300) ºC (300 to 400) ºC (400 to 600) ºC (600 to 630) ºC	0.04 ºC 0.04 ºC 0.04 ºC 0.05 ºC 0.12 ºC 0.13 ºC 0.14 ºC 0.16 ºC	

II. Mechanical

Parameter/Equipment	Range	CMC[2, 4] (±)	Comments
Pressure –			
Differential	(-1 to 1) inH_2O (-30 to 30) inH_2O (-60 to 60) inH_2O	0.00015 inH_2O 0.01 % 0.009 %	Ruska 7250LP
	(0 to 30) psig (30 to 300) psig	0.0021 psig 0.009 %	DHI PPC3 pressure calibrator
Pneumatic	(0 to 30) psia (30 to 300) psia	0.0042 psia 0.009 % rdg + 0.0036 psia	See Footnote 6
Hydraulic	(100 to 10 000) psi	0.04 %	Ametek DM-T-100-1 deadweight tester
Barometric	(750 to 1150) mbar	0.25 mbar	GE/Druck DPI 150 barometer

Parameter/Equipment	Range	CMC[2] (±)	Comments
Vacuum	(0 to -14.5) psig	0.0042 psig	DHI PPC3 pressure calibrator See Footnote 6

III. Thermodynamic

Parameter/Equipment	Range	CMC[2, 4] (±)	Comments
Temperature – Measure	(-200 to 480) ºC (480 to 660) ºC	0.008 ºC 0.016 ºC	SPRT and Superthermometer
Temperature – Measuring Equipment	(-80 to -30) ºC (-30 to 100) ºC (100 to 300) ºC (300 to 660) ºC -196 ºC -38.83 ºC 0.01 ºC 231.928 ºC 419.527 ºC 660.323 ºC (-15 to 35) ºC (35 to 200) ºC (200 to 500) ºC	0.014 ºC 0.012 ºC 0.015 ºC 0.36 ºC 7 mK (0.007 ºC) 6 mK (0.006 ºC) 3 mK (0.003 ºC) 4 mK (0.004 ºC) 6 mK (0.006 ºC) 9 mK (0.009 ºC) 0.5 ºC 0.23 % + 0.35 ºC 0.30 % + 0.20 ºC	Temperature baths, temperature chamber, dry well calibrator Liquid nitrogen & fixed points Infrared calibrator
Relative Humidity – Measuring Equipment Dew point Temperature	(10 to 95) % RH (-30 to +30) ºC	0.6 % RH 0.1 ºC	Thunder Scientific 2500ST humidity chamber

IV. Time and Frequency

Parameter/Equipment	Range	CMC[2] (±)	Comments
Frequency – Measure	DC to 225 MHz	0.001 % + 0.008 Hz	Agilent 53131A (frequency counter)

Field Calibration Services:

V. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC[2, 4] (±)	Comments
DC Voltage – Measure[3]	(0 to 110) mV 110 mV to 1.1 V (1.1 to 11) V (11 to 110) V (110 to 300) V	0.025 % + 0.015 % fs 0.025 % + 0.005 % fs 0.025 % + 0.005 % fs 0.05 % + 0.015 % fs 0.05 % + 0.015 % fs	Fluke 744
DC Voltage – Generate[3]	(0 to 110) mV 110 mV to 1.1 V (1.1 to 15) V	0.01 % + 0.005 % fs 0.01 % + 0.005 % fs 0.01 % + 0.005 % fs	Fluke 744
DC Current – Measure[3]	(0 to 30) mA (30 to 110) mA	0.01 % + 0.15 % fs 0.01 % + 0.15 % fs	Fluke 744
DC Current – Generate[3] Tx Simulator	(0 to 22) mA	0.01 % + 0.015 % fs	Fluke 744
Resistance – Measure[5]	(0 to 11) Ω (11 to 110) Ω 110 Ω to 1.1 kΩ (1.1 to 11) kΩ	0.055 Ω 0.11 Ω 1.1 Ω 21 Ω	Fluke 744
Resistance – Generate[5]	(0 to 11) Ω (11 to 110) Ω 110 Ω to 1.1 kΩ (1.1 to 11) kΩ	0.021 Ω 0.051 Ω 0.72 Ω 8.3 Ω	Fluke 744

Parameter/Equipment	Range	CMC[2] (±)	Comments
AC Frequency – Measure[3]	(1 to 109.99) Hz (110 to 1099.9) Hz (1.1 to 10.999) kHz (11 to 50) kHz	0.05 Hz 0.5 Hz 0.005 kHz 0.05 kHz	Fluke 744
AC Frequency – Generate[3]	(1 to 10.99) Hz (11 to 109.9) Hz (110 to 1099.9) Hz (1.1 to 21.99) kHz (22 to 50) kHz	0.01 Hz 0.01 Hz 0.01 Hz 0.002 kHz 0.005 kHz	Fluke 744
AC Voltage – Measure[3] (0 to 300) V	 (40 to 500) Hz	 0.5 % + 5 counts	 Fluke 744
Electrical Calibration of Thermocouples and Thermocouple Indicating Devices – Measure[3] Type J Type K Type T	 (-210 to -100) ºC (-100 to 800) ºC (800 to 1200) ºC (-210 to -100) ºC (-100 to 400) ºC (400 to 1200) ºC (1200 to 1372) °C (-250 to -200) ºC (-200 to 0) ºC (0 to 400) ºC	 0.6 °C 0.3 °C 0.5 °C 0.7 °C 0.3 °C 0.5 °C 0.7 °C 1.7 °C 0.6 °C 0.3 °C	 Fluke 744

Parameter/Equipment	Range	CMC[2] (±)	Comments
Electrical Calibration of RTD Indicating Devices – Generate[3, 5]			
Pt 385, 100 Ω	(-200 to 0) ºC (0 to 400) ºC (400 to 800) ºC	0.1 °C 0.2 °C 0.4 °C	Fluke 744
Pt 385, 1000 Ω	(-200 to 0) ºC (0 to 400) ºC (400 to 800) ºC	0.1 °C 0.2 °C 0.4 °C	
Pt 3926, 100 Ω	(-200 to 0) ºC (0 to 630) ºC	0.1 °C 0.2 °C	
Pt 3916, 100 Ω	(-200 to -190) ºC (-190 to 0) ºC (0 to 630) ºC	0.3 °C 0.1 °C 0.2 °C	
Electrical Calibration of RTD Indicating Devices – Measure[3, 5]			
Pt 385, 100 Ω	(-200 to 0) ºC (0 to 400) ºC (400 to 800) ºC	0.3 °C 0.5 °C 0.8 °C	Fluke 744
Pt 385, 1000 Ω	(-200 to 0) ºC (0 to 400) ºC (400 to 800) ºC	0.3 °C 0.5 °C 0.8 °C	
Pt 3926, 100 Ω	(-200 to 0) ºC (0 to 630) ºC	0.3 °C 0.5 °C	
Pt 3916, 100 Ω	(-200 to -190) ºC (-190 to 0) ºC (0 to 630) ºC	0.3 °C 0.3 °C 0.5 °C	

VI. Mechanical

Parameter/Equipment	Range	CMC[2, 4] (±)	Comments
Pressure[3] –			
Pneumatic	(-1 to +1) inH_2O (-15 to +15) inH_2O	0.22 % + 0.0012 inH_2O 0.22 % + 0.014 inH_2O	Setra 869
	(0 to 150) psia (0 to 150) psig	0.037 psia 0.037 psig	GE/Druck DPI 150 digital indicator
	(150 to 500) psig	0.12 %	Crystal Eng Gage
Barometric	(750 to 1150) mbar	0.25 mbar	GE/Druck DPI 150 barometer
Vacuum – Pneumatic[3]	(0 to -14.5) psig	0.037 psig	GE/Druck DPI 150 digital indicator

VII. Thermodynamics

Parameter/Equipment	Range	CMC[2] (±)	Comments
Temperature – Measure[3]	(-200 to 660) ºC	0.047 ºC	Digital thermometers and PRT
	(0 to 660) ºC	0.9 ºC	Digital thermometers and thermocouples
Temperature – Measuring Equipment[3]	(-45 to 100) ºC (100 to 660) ºC	0.1 °C 0.36 °C	Dry well calibrator
Humidity – Measure[3]	(10 to 90) % RH	0.9 % RH	Rotronic HygroClip HC2
Humidity – Measuring Eqipment[3]	(10 to 90) % RH	1.0 % RH	Rotronic HygroGen 2A

[1] This laboratory offers commercial and field calibration services, where noted.

[2] Calibration and Measurement Capability (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. Calibration and Measurement Capabilities represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

[3] Field calibration service is available for this calibration and this laboratory meets A2LA *R104 – General Requirements: Accreditation of Field Testing and Field Calibration Laboratories* for these calibrations. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the actual uncertainty introduced by the item being calibrated, (e.g. resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

[4] In the statement of CMC, percentages are percentages of reading/output, unless otherwise noted.

[5] The method used for the CMC is a 4 wire method

[6] Auto zero function performed referenced to a standard barometer.

The American Association for Laboratory Accreditation

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for technical competence in the field of

Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 *General Requirements for the Competence of Testing and Calibration Laboratories*. This laboratory also meets the requirements of ANSI/NCSLI Z540-1-1994 and the requirements of ANSI/NCSLI Z540.3-2006 and any additional program requirements in the field of calibration. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (*refer to joint ISO-ILAC-IAF Communiqué dated 8 January 2009*).

Presented this 9th day of February 2011.

President & CEO
For the Accreditation Council
Certificate Number 2260.01
Valid to January 31, 2013

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.